

Notice of References Cited	Application/Control No. 09/934,297	Applicant(s)/Patent Under Reexamination VAN EYK ET AL.	
	Examiner Ann Y. Lam	Art Unit 1641	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,508,202	04-1996	Enomoto et al.	436/69
	B	US-5,840,508	11-1998	Switchenko et al.	435/7.32
	C	US-4,376,825	03-1983	Rubenstein et al.	435/188
	D	US-4,563,423	01-1986	Murray et al.	435/69.3
	E	US-6,322,976	11-2001	Aitman et al.	435/6
	F	US-4,654,419	03-1987	Vaughan et al.	530/326
	G	US-6,020,139	02-2000	Schwartz et al.	435/7.1
	H	US-5,616,460	04-1997	Figard, Steve D.	435/5
	I	US-5,994,507	11-1999	Pilotti et al.	530/362
	J	US-4,376,825	03-1983	Rubenstein et al.	435/188
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.